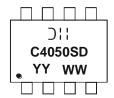


Marking Information



Oll = Manufacturer's Marking C4050SD = Product Type Marking Code YYWW = Date Code Marking YY or YY = Year (ex: 20 = 2020) WW = Week (01 - 53)

Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

| Characteristic | | | Symbol | N-Channel - Q1 | P-Channel - Q2 | Units |
|--|-----------------------|--------------------------------------|------------------|----------------|----------------|-------|
| Drain-Source Voltage | | | V_{DSS} | 40 | -40 | V |
| Gate-Source Voltage | | | V _{GSS} | ±20 | ±20 | V |
| Continuous Drain Current | V _{GS} = 10V | (Notes 6 & 8) | ID | 5.8 | -5.8 | A |
| | | T _A = +70°C (Notes 6 & 8) | | 4.38 | -4.52 | |
| | | (Notes 5 & 8) | | 4.2 | -4.2 | |
| | | (Notes 5 & 9) | | 5.3 | -5.3 | |
| Pulsed Drain Current | $V_{GS} = 10V$ | (Notes 7 & 8) | I_{DM} | 24.1 | -24.9 | |
| Continuous Source Current (Body Diode) | | (Notes 6 & 8) | Is | 2.5 | -2.5 | |
| Pulsed Source Current (Body Diode) (Notes 7 & 8) | | (Notes 7 & 8) | I _{SM} | 24.1 | -24.9 | |

Thermal Characteristics

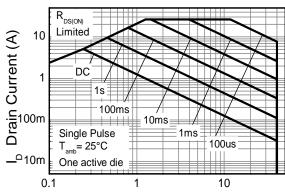
| Characteristic | Symbol | Value | Unit | | |
|---|----------------------------------|------------------|------|------------|--|
| Power Dissipation | (Notes 5 & 8) | | 1.25 | 10/ | |
| Linear Derating Factor | (Notes 5 & 9) | PD | 1.8 | W mW/°C | |
| | (Notes 6 & 8) | | 2.14 | mivv/ C | |
| | (Notes 5 & 8) | | 100 | | |
| Thermal Resistance, Junction to Ambient | (Notes 5 & 9) | R _{θJA} | 70 | 0044 | |
| | (Notes 6 & 8) | | 58 | °C/W | |
| Thermal Resistance, Junction to Lead | (Notes 5 & 10) | $R_{\theta JL}$ | 51 | | |
| Operating and Storage Temperature Range | T _{J,} T _{STG} | -55 to +150 | °C | | |

Notes:

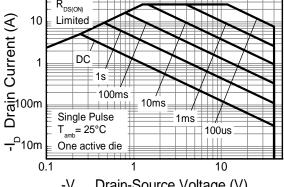
- 5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 6. Same as note (5), except the device is measured at $t \leq 10 \mbox{ sec.}$
- 7. Same as note (5), except the device is pulsed with D = 0.02 and pulse width $300\mu s$.
- 8. For a dual device with one active die.
- 9. For a device with two active die running at equal power.
- 10. Thermal resistance from junction to solder-point (at the end of the drain lead).



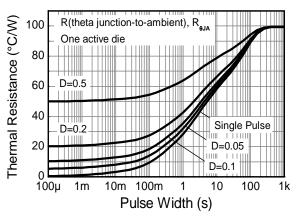
Thermal Characteristics (continued)



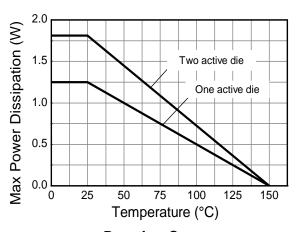
V_{DS} Drain-Source Voltage (V) **N-channel Safe Operating Area**



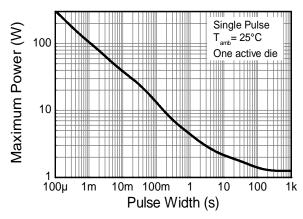
-V_{DS} Drain-Source Voltage (V) **P-channel Safe Operating Area**



Transient Thermal Impedance



Derating Curve



Pulse Power Dissipation



Electrical Characteristics (Q1 N-Channel) (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition | |
|--|-----------------------------------|-----|----------|----------|------|---|--|
| OFF CHARACTERISTICS (Note 11) | | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | 40 | _ | _ | V | $V_{GS} = 0V, I_D = 250\mu A$ | |
| Zero Gate Voltage Drain Current T _J = +25°C | I _{DSS} | l | | 1.0 | μΑ | $V_{DS} = 40V$, $V_{GS} = 0V$ | |
| Gate-Source Leakage | I _{GSS} | l | - | ±100 | nA | $V_{GS} = \pm 20V, V_{DS} = 0V$ | |
| ON CHARACTERISTICS (Note 11) | | | | | | | |
| Gate Threshold Voltage | $V_{GS(th)}$ | 8.0 | 1.3 | 1.8 | V | $V_{DS} = V_{GS}$, $I_D = 250\mu A$ | |
| Static Drain-Source On-Resistance | B-s/s/ | _ | 20 33 | 45 60 | mΩ | $V_{GS} = 10V, I_D = 3A$ | |
| Static Drain-Source on-Resistance | R _{DS(ON)} | | | | | $V_{GS} = 4.5V, I_D = 3A$ | |
| Forward Transfer Admittance | Y _{fs} | 1 | 12.6 | _ | S | $V_{DS} = 5V, I_{D} = 3A$ | |
| Diode Forward Voltage (Note 11) | V_{SD} | | 0.7 | 1.0 | V | $V_{GS} = 0V, I_{S} = 1A$ | |
| DYNAMIC CHARACTERISTICS (Note 12) | DYNAMIC CHARACTERISTICS (Note 12) | | | | | | |
| Input Capacitance | Ciss | 1 | 1790.8 | _ | pF | \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ | |
| Output Capacitance | Coss | l | 160.6 | | pF | $V_{DS} = 20V, V_{GS} = 0V,$ f = 1.0MHz | |
| Reverse Transfer Capacitance | C_{rss} | | 120.5 | _ | pF | | |
| Gate Resistance | R_g | | 1.03 | _ | Ω | $V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$ | |
| Total Gate Charge | Q_{g} | _ | 37.56 | _ | nC | 101/11/ 001/ | |
| Gate-Source Charge | Q_{gs} | _ | 7.8 | _ | nC | $V_{GS} = 10V, V_{DS} = 20V,$ | |
| Gate-Drain Charge | Q_{gd} | _ | 6.6 | _ | nC | $I_D = 3A$ | |
| Turn-On Delay Time | t _{D(on)} | _ | 8.08 | _ | nS | | |
| Turn-On Rise Time | t _r | _ | 15.14 | _ | nS | V _{GS} = 10V, V _{DS} = 20V, | |
| Turn-Off Delay Time | t _{D(off)} | _ | 24.29 | _ | nS | $I_D = 3A$ | |
| Turn-Off Fall Time | tf | | 5.27 | _ | nS | | |

Electrical Characteristics (Q2 P-Channel) (@T_A = +25°C, unless otherwise specified.)

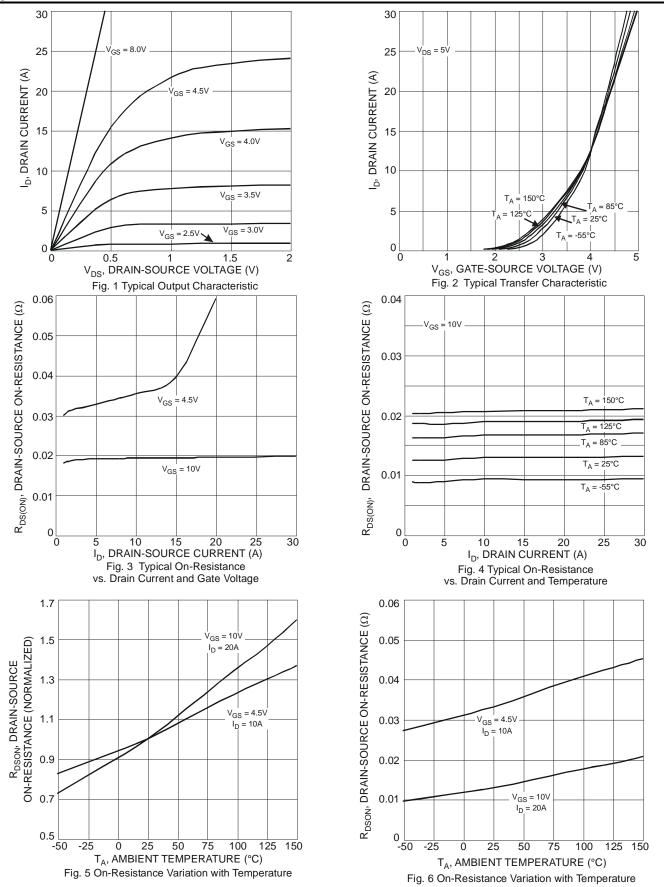
| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition | |
|--|---------------------|------|---------|------|-------|--|--|
| OFF CHARACTERISTICS (Note 11) | | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | -40 | _ | _ | V | $V_{GS} = 0V, I_D = -250\mu A$ | |
| Zero Gate Voltage Drain Current T _J = +25°C | I _{DSS} | 1 | _ | -1.0 | μΑ | V _{DS} = -40V, V _{GS} = 0V | |
| Gate-Source Leakage | I _{GSS} | _ | _ | ±100 | nA | $V_{GS} = \pm 20V, V_{DS} = 0V$ | |
| ON CHARACTERISTICS (Note 11) | | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | -0.8 | -1.3 | -1.8 | ٧ | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | |
| Static Drain-Source On-Resistance | | _ | 28 | 45 | mΩ | $V_{GS} = -10V, I_D = -3A$ | |
| Static Dialii-Source Oil-Resistance | R _{DS(ON)} | | 30 | 60 | 11122 | $V_{GS} = -4.5V, I_{D} = -3A$ | |
| Forward Transfer Admittance | Y _{fs} | 1 | 16.6 | _ | S | $V_{DS} = -5V, I_{D} = -3A$ | |
| Diode Forward Voltage (Note 11) | V_{SD} | 1 | -0.7 | -1.0 | V | $V_{GS} = 0V, I_{S} = -1A$ | |
| DYNAMIC CHARACTERISTICS (Note 12) | | | | | | | |
| Input Capacitance | C _{iss} | 1 | 1643.17 | | рF | N 00 V V 0 0 V | |
| Output Capacitance | C _{oss} | l | 179.13 | l | рF | $V_{DS} = -20V, V_{GS} = 0V,$ f = 1.0MHz | |
| Reverse Transfer Capacitance | C _{rss} | 1 | 127.82 | - | pF | | |
| Gate Resistance | Rg | 1 | 6.43 | _ | Ω | $V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$ | |
| Total Gate Charge | Qg | 1 | 33.66 | - | nC | 10)/)/ 20)/ | |
| Gate-Source Charge | Q _{gs} | _ | 5.54 | _ | nC | $V_{GS} = -10V, V_{DS} = -20V,$ | |
| Gate-Drain Charge | Q _{gd} | | 7.30 | _ | nC | $I_D = -3A$ | |
| Turn-On Delay Time | t _{D(on)} | _ | 6.85 | _ | nS | | |
| Turn-On Rise Time | t _r | | 14.72 | _ | nS | $V_{GS} = -10V, V_{DS} = -20V,$ | |
| Turn-Off Delay Time | t _{D(off)} | _ | 53.65 | _ | nS | I _D = -3A | |
| Turn-Off Fall Time | t _f | _ | 30.86 | _ | nS | | |

Notes:

Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to production testing.



Typical Characteristics (Q1 N-Channel)





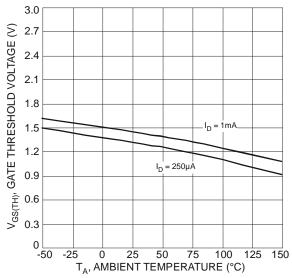
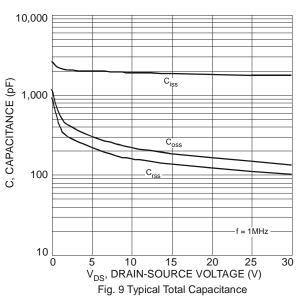
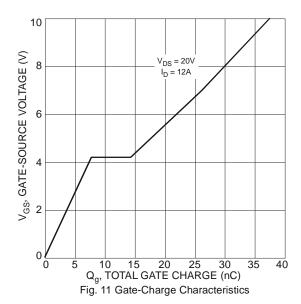
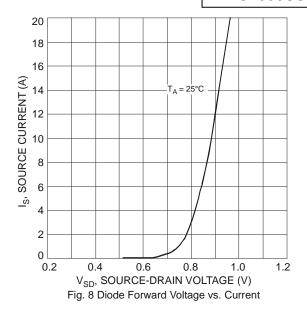
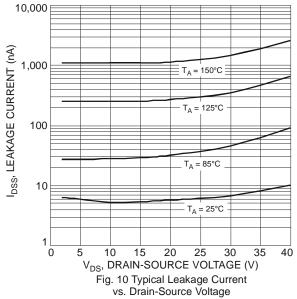


Fig. 7 Gate Threshold Variation vs. Ambient Temperature











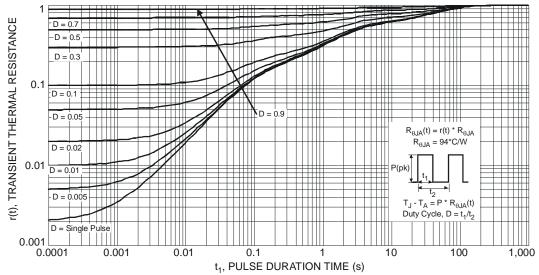
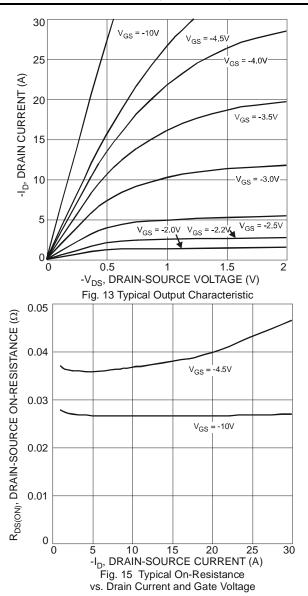
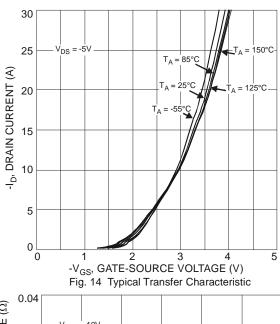


Fig. 12 Transient Thermal Response



Typical Characteristics (Q2 P-Channel)





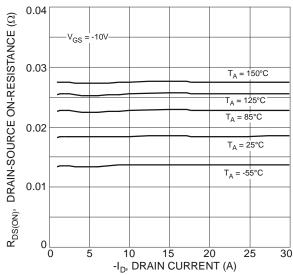
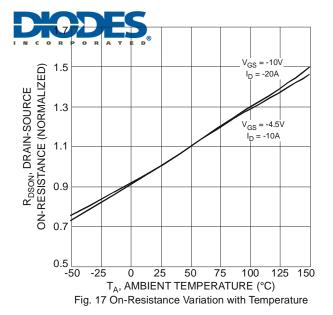


Fig. 16 Typical On-Resistance vs. Drain Current and Temperature



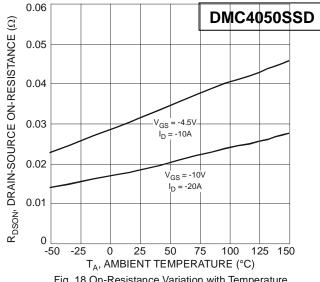
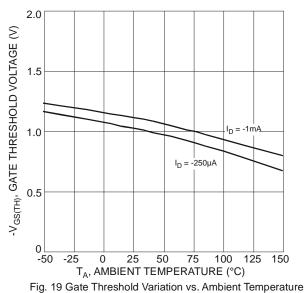
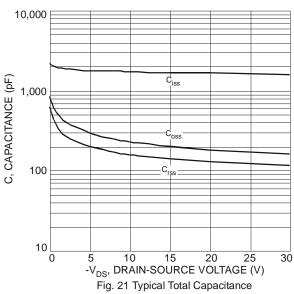
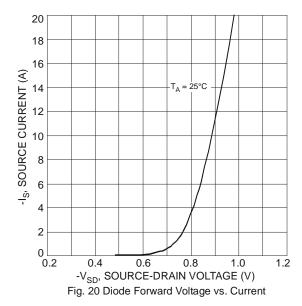


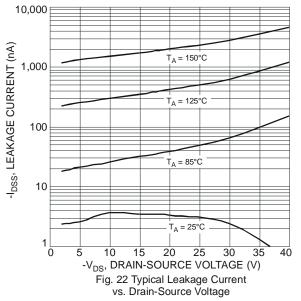
Fig. 18 On-Resistance Variation with Temperature

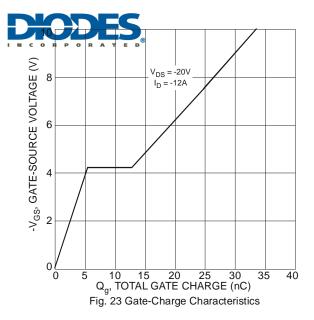


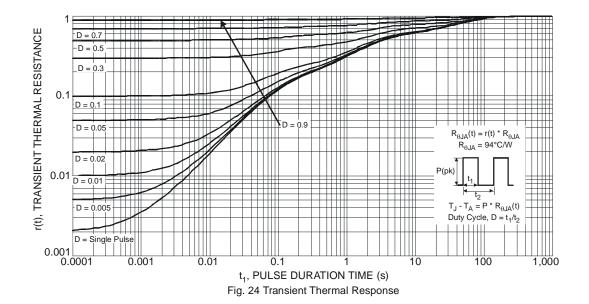








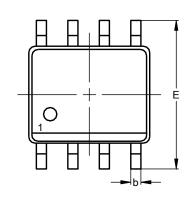


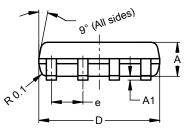


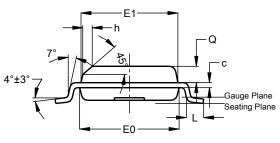


Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.







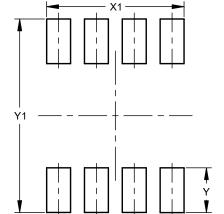
SO-8

SO-8

| SO-8 | | | | | |
|----------------------|-----------|------|------|--|--|
| Dim | Min | Max | Тур | | |
| Α | 1.40 | 1.50 | 1.45 | | |
| A1 | 0.10 | 0.20 | 0.15 | | |
| b | 0.30 | 0.50 | 0.40 | | |
| С | 0.15 | 0.25 | 0.20 | | |
| D | 4.85 4.95 | | 4.90 | | |
| Е | 5.90 | 6.10 | 6.00 | | |
| E1 | 3.80 | 3.90 | 3.85 | | |
| E0 | 3.85 | 3.95 | 3.90 | | |
| е | е | | 1.27 | | |
| h | 1 | | 0.35 | | |
| L | 0.62 | 0.82 | 0.72 | | |
| Q | 0.60 | 0.70 | 0.65 | | |
| All Dimensions in mm | | | | | |

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



| Dimensions | Value (in mm) |
|------------|---------------|
| С | 1.27 |
| Х | 0.802 |
| X1 | 4.612 |
| Y | 1.505 |
| Y1 | 6.50 |



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